
Transmission Electron Microscopy Characterization of Nanomaterials

Challa S. S. R. Kumar
Editor

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With 403 Figures and 15 Tables

 Springer

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Baton Rouge, LA, USA

ISBN 978-3-642-38933-7 ISBN 978-3-642-38934-4 (eBook)

DOI 10.1007/978-3-642-38934-4

Springer Heidelberg New York Dordrecht London

Library of Congress Control Number: 2013955568

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Printed on acid-free paper

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